



**NATIONAL INSTITUTE OF TECHNOLOGY,  
TIRUCHIRAPPALLI-620015**

**Department of Instrumentation and Control Engineering**  
**Syllabus for written test**

**Electricity and Magnetism**

Coulomb's Law, Electric Field Intensity, Electric Flux Density, Gauss's Law, Divergence, Electric field and potential due to point, line, plane, and spherical charge distributions, Effect of the dielectric medium, Capacitance of simple configurations, Biot-Savart's law, Ampere's law, Curl, Faraday's law, Lorentz force, Inductance,

Magnetomotive force, Reluctance, Magnetic circuits, Self and Mutual inductance of simple configurations.

**Electrical Circuits and Machines**

Voltage and current sources: independent, dependent, ideal and practical; v-i relationships of resistor, inductor, mutual inductance and capacitor; transient analysis of RLC circuits with dc excitation.

Kirchoff's laws, mesh and nodal analysis, superposition, Thevenin, Norton, maximum power transfer and reciprocity theorems. Peak-, average- and rms values of ac quantities; apparent-, active- and reactive powers; phasor analysis, impedance and admittance; series and parallel resonance, locus diagrams, realization of basic filters with R, L and C elements. transient analysis of RLC circuits with ac excitation.

One-port and two-port networks, driving point impedance and admittance, open-, and short circuit parameters. Single-phase transformer: equivalent circuit, phasor diagram, open circuit and short circuit tests, regulation and efficiency; Three-phase induction motors: principle of operation, types, performance, torque-speed characteristics, no-load and blocked rotor tests, equivalent circuit, starting and speed control; Types of losses and efficiency calculations of electric machines

**Signals and Systems**

Periodic, aperiodic and impulse signals; Laplace, Fourier and z-transforms; transfer function, frequency response of first and second-order linear time-invariant systems, impulse response of systems; convolution, correlation. Discrete-time system: impulse response, frequency response, pulse transfer function; DFT and FFT; basics of IIR and FIR filters.

**Control Systems**

Convolution, Integral, Ordinary differential equation, Transfer function, Feedback principles, signal flow graphs, transient response, steady-state-errors, Bode plot, phase and gain margins,

Routh and Nyquist criteria, root loci, Pole zero concepts, effect of pole location on performance specification. design of lead, lag and lead-lag compensators, System models in state space, canonical model, MIMO systems, solution of state equation, stability of systems in state space, State feedback, controller/observer design. Controllability, Observability; time-delay systems; mechanical, hydraulic and pneumatic system components, synchro pair, servo and stepper motors, servo valves; on-off, P, PI, PID, cascade, feedforward, and ratio controllers, tuning of PID controllers and sizing of control valves.

### **Analog Electronics**

Characteristics and applications of diode, Zener diode, BJT and MOSFET; small-signal analysis of transistor circuits, feedback amplifiers. Characteristics of ideal and practical operational amplifiers; applications of opamps: adder, subtractor, integrator, differentiator, difference amplifier, instrumentation amplifier, precision rectifier, active filters, oscillators, signal generators, voltage-controlled oscillators and phase-locked loop, sources and effects of noise and interference in electronic circuits.

### **Digital Electronics**

Combinational logic circuits, minimization of Boolean functions. IC families: TTL and CMOS. Arithmetic circuits, comparators, Schmitt trigger, multi-vibrators, sequential circuits, flipflops, shift registers, timers and counters; sample-and-hold circuit, multiplexer, analog-to-digital (successive approximation, integrating, flash and sigma-delta) and digital-to-analog converters (weighted R, R-2R ladder and current steering logic). Characteristics of ADC and DAC (resolution, quantization, significant bits, conversion/settling time); basics of number systems, Embedded Systems: Microprocessor and microcontroller applications, memory and input-output interfacing; basics of data acquisition systems, basics of distributed control systems (DCS) and programmable logic controllers (PLC).

### **Measurements**

SI units, standards (R, L, C, voltage, current and frequency), systematic and random errors in measurement, expression of uncertainty - accuracy and precision, propagation of errors, linear and weighted regression.

Bridges: Wheatstone, Kelvin, Megohm, Maxwell, Anderson, Schering and Wien for measurement of R, L, C and frequency, Q-meter. Measurement of voltage, current and power in single and three phase circuits; ac and dc current probes; true rms meters, voltage and current scaling, instrument transformers, timer/counter, time, phase and frequency measurements, digital voltmeter, digital multimeter; oscilloscope, shielding and grounding.

### **Sensors and Industrial Instrumentation**

Resistive-, capacitive-, inductive-, piezoelectric-, Hall effect sensors and associated signal conditioning circuits; transducers for industrial instrumentation: displacement (linear and angular), velocity, acceleration, force, torque, vibration, shock, pressure (including low pressure), flow (variable head, variable area, electromagnetic, ultrasonic, turbine and open

channel flow meters) temperature (thermocouple, bolometer, RTD (3/4 wire), thermistor, pyrometer and semiconductor); liquid level, pH, conductivity and viscosity measurement. 4-20 mA two-wire transmitter.

### **Communication and Optical Instrumentation**

Amplitude- and frequency modulation and demodulation; Shannon's sampling theorem, pulse code modulation; frequency and time division multiplexing, amplitude-, phase-, frequency-, quadrature amplitude, pulse shift keying for digital modulation; optical sources and detectors: LED, laser, photo-diode, light-dependent resistor, square-law detectors, and their characteristics; interferometer: applications in metrology; basics of fiber optic sensing. UV-VIS Spectrophotometers, Mass spectrometer.